PNZ300 (PN300), PNZ300F (PN300F)

Silicon planar type

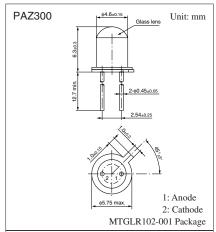
For optical control systems

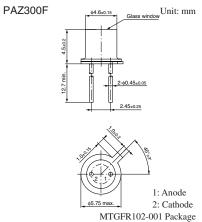
■ Features

- Fast response which is well suited to high speed modulated light detection
- Wide spectral sensitivity
- Low dark current and low noise
- Good photo current linearity and wide dynamic sensitivity
- Narrow directivity (PNZ300)
- Wide derectivity (PNZ300F)

\blacksquare Absolute Maximum Ratings $T_a = 25 ^{\circ}C$

Parameter	Symbol	Rating	Unit
Reverse voltage	V _R	50	V
Power dissipation	P_{D}	100	mW
Operating ambient temperature	T_{opr}	-25 to +85	°C
Storage temperature	T _{stg}	-30 to +100	°C

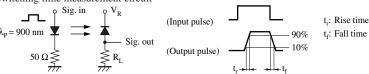




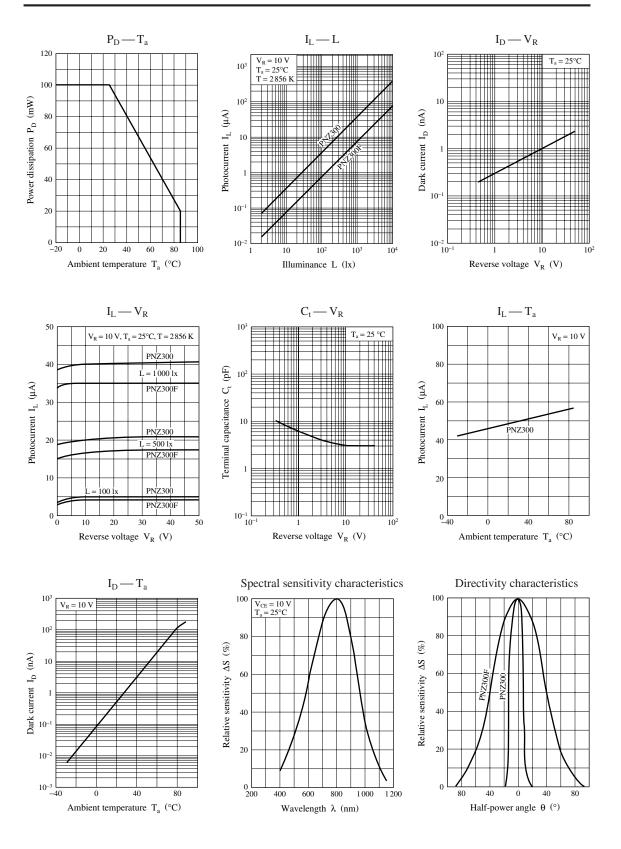
■ Electrical-Optical Characteristics $T_a = 25$ °C ± 3 °C

Parameter		Symbol	Conditions	Min	Тур	Max	Unit
Dark current		I_D	$V_R = 10 \text{ V}$		0.1	10	nA
Photocurrent *1	PNZ300	I_L	$V_R = 10 \text{ V}, L = 1000 \text{ lx}$	30	55		μΑ
	PNZ300F			5	7		
Peak emission wavelength		λ_{p}	$V_R = 10 \text{ V}$		800		nm
Rise time *2		t _r	$V_R = 20 \text{ V}, R_L = 50 \Omega$		1		ns
Fall time *2		t_{f}			1		ns
Terminal capacitance		C_{t}	$V_R = 10 \text{ V, } f = 1 \text{ MHz}$		7		pF
Half-power angle	PNZ300	θ	The angle from which photocurrent		10		0
	PNZ300F		becomes 50%		40		

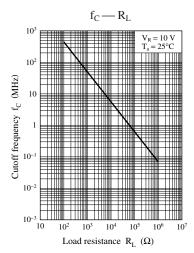
- $Note) \ 1. \ Measuring \ methods \ are \ based \ on \ JAPANESE \ INDUSTRIAL \ STANDARD \ JIS \ C \ 7031 \ measuring \ methods \ for \ diodes.$
 - 2. Spectral sensitivity characteristics: Sensitivity for wave length over 400 nm maximum sensitivity ratio is 100%.
 - 3. This device is designed be disregarded radiation.
 - 4. *1: Source: Tungsten (color temperature 2856 K)
 - *2: Switching time measurement circuit



Note) The part numbers in the parenthesis show conventional part number.



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SHE00030BED 3

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